

#### DESCRIPTION

The SSFN6816 uses advanced trench technology to provide excellent  $R_{\mathrm{DS(ON)}},$  low gate charge and operation with gate voltages as low as 2.5V while retaining a 12V  $V_{\mathrm{GS(MAX)}}$  rating. It is ESD protected. This device is suitable for use as a uni-directional or bi-directional load switch, facilitated by its common-drain configuration.

### **GENERAL FEATURES**

•  $V_{DS} = 30V, I_{D} = 8A$ 

 $R_{DS(ON)} < 30 \text{m}\Omega$  @  $V_{GS} = 2.5 \text{V}$ 

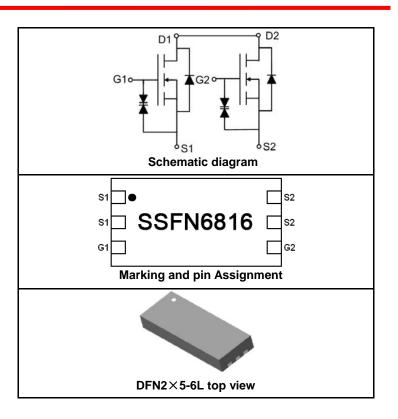
 $R_{DS(ON)}$  < 24m $\Omega$  @  $V_{GS}$ =3.1V

 $R_{DS(ON)} < 22m\Omega @ V_{GS} = 4.0V$ 

 $R_{DS(ON)}$  < 20m $\Omega$  @  $V_{GS}$ =4.5V

ESD Rating: 2000V HBM

- High Power and current handing capability
- Lead free product is acquired
- Surface Mount Package



#### PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
SSFN6816	SSFN6816	DFN2×5-6L			3000 units

ABSOLUTE MAXIMUM RATINGS(TA=25℃ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	30	V
Gate-Source Voltage	V <sub>G</sub> s	±12	V
Drain Current Continuous & Current Duland (Note 1)	I <sub>D</sub>	8	А
Drain Current-Continuous@ Current-Pulsed (Note 1)	I <sub>DM</sub>	45	А
Maximum Power Dissipation	P <sub>D</sub>	1.7	W
Operating Junction and Storage Temperature Range	$T_{J}, T_{STG}$	-55 To 150	$^{\circ}\!\mathbb{C}$

#### THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{ heta JA}$	40	°C/W
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**ELECTRICAL CHARACTERISTICS (TA=25°C unless otherwise noted)** 

Parameter	Symbol	Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	30			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =30V,V <sub>GS</sub> =0V			1	μA



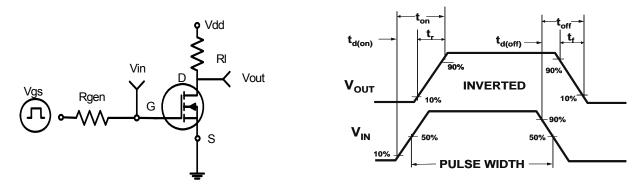
Gate-Body Leakage Current	I <sub>GSS</sub>	$V_{GS}$ =±10V, $V_{DS}$ =0V			10	uA
Gate-Source Breakdown Voltage	BV <sub>GSO</sub>	V <sub>DS</sub> =0V, I <sub>G</sub> =±250uA	±12			V
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA	0.6	1	1.5	V
		V <sub>GS</sub> =10V, I <sub>D</sub> =8A		14	17	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =6A		17	20	
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =4.0V, I <sub>D</sub> =4A		18	22	
		V <sub>GS</sub> =3.1V, I <sub>D</sub> =4A		20	24	
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =3A		23	30	
Forward Transconductance	<b>g</b> FS	V <sub>DS</sub> =5V,I <sub>D</sub> =8A		17		S
DYNAMIC CHARACTERISTICS (Note4)						
Input Capacitance	C <sub>lss</sub>			870		PF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> =15V,V <sub>GS</sub> =0V, F=1.0MHz		130		PF
Reverse Transfer Capacitance	C <sub>rss</sub>			100		PF
Gate resistance	Rg	V <sub>DS</sub> =0V,V <sub>GS</sub> =0V, F=1.0MHz		1.5		Ω
SWITCHING CHARACTERISTICS (Note 4)	)					
Turn-on Delay Time	t <sub>d(on)</sub>			4		nS
Turn-on Rise Time	t <sub>r</sub>	V <sub>DD</sub> =15V,V <sub>GS</sub> =10V,		10		nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_{GEN}=3\Omega$ , $R_L=1.25\Omega$		28		nS
Turn-Off Fall Time	t <sub>f</sub>			7		nS
Total Gate Charge	Qg			10.5		nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> =15V,I <sub>D</sub> =8A,V <sub>GS</sub> =4.5V		1.9		nC
Gate-Drain Charge	$Q_{gd}$			4.1		nC
DRAIN-SOURCE DIODE CHARACTERIST	ics	1	ı		<u> </u>	
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =1A		0.76	0.9	V
Diode Forward Current (Note 2)	Is				4.5	Α

# **NOTES:**

- Repetitive Rating: Pulse width limited by maximum junction temperature.
  Surface Mounted on FR4 Board, t ≤ 10 sec.
  Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
  Guaranteed by design, not subject to production testing.

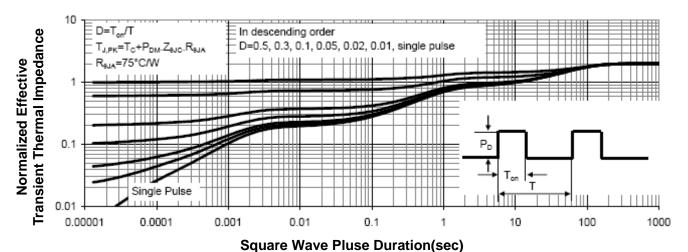


# TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



**Figure 1: Switching Test Circuit** 

Figure 2:Switching Waveforms

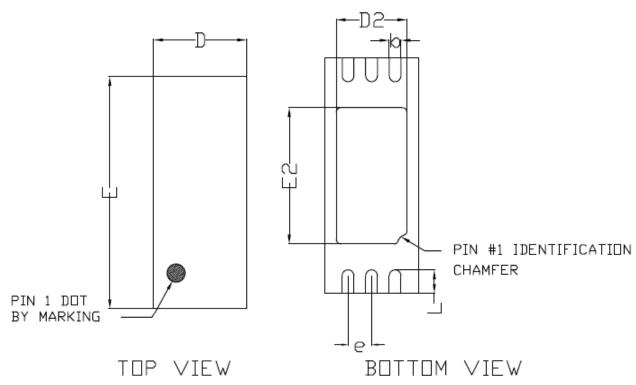


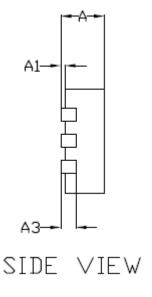
**Figure 3: Normalized Maximum Transient Thermal Impedance** 



# **DFN2×5-6L PACKAGE INFORMATION**

# **Dimensions in Millimeters (UNIT:mm)**





COMMON DIMENSIONS(MM)						
PKG.	W:VERY VERY THIN					
REF.	MIN.	MIN. NOM. MA				
Α	0.70	0.75	0.80			
<b>A</b> 1	0.00	_	0.05			
А3	0.2 REF.					
D	1.95	5 2.00 2.0				
E	4.95	5.00	5.05			
D2	1.35	1.50	1.60			
E2	2.75	2.90	3.00			
L	0.40	0.50	0.60			
b	0.20	0.25	0.30			
е	0.5 BCS.					

# **NOTES**

- 1. All dimensions are in millimeters.
- 2. Tolerance ±0.10mm (4 mil) unless otherwise specified
- 3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
- 4. Dimension L is measured in gauge plane.
- 5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.



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